



Where every mil or micron counts



## The right solution

Coating thickness measurement based on X-ray fluorescence (XRF) is an industry-proven technique, offering fast and non-destructive analysis.

The X-Strata920 is designed to measure single-layer and multi-layer coatings – including alloyed layers – for both the electronics and metal finishing industries. Our in-house applications experts have optimised the X-Strata920 to ensure you get reliable, repeatable results for hundreds of applications including PCB surface finishes, connector coatings, corrosion resistance, decorative finishes, wear resistance, high temperature resistance and more.

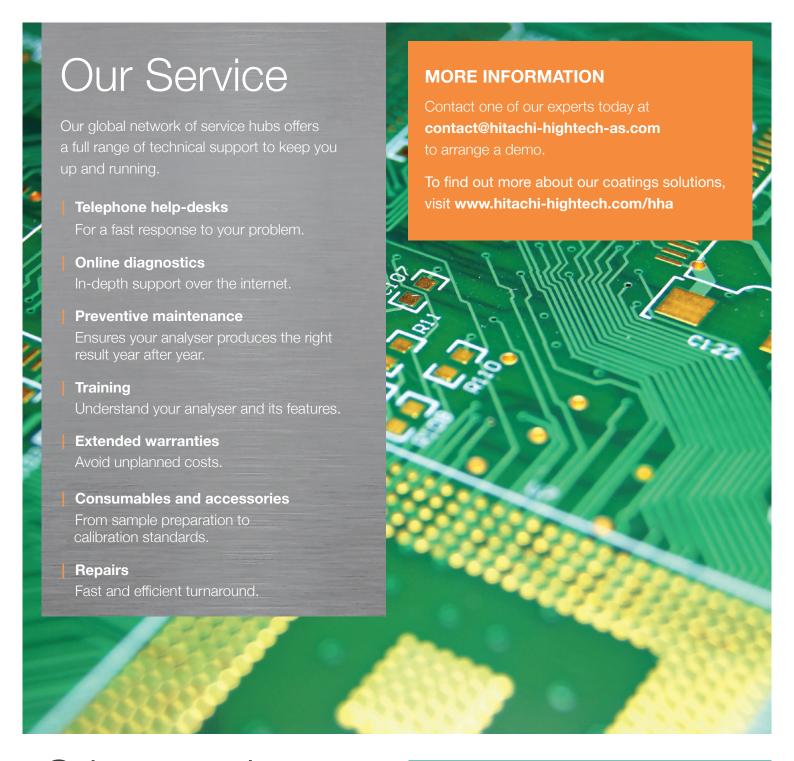
Where every mil or micron counts, the X-Strata920 gives you the precision and reliable results you need.











## Other products

We have been providing industrial analysis products for the coatings market for over 40 years.

- **Micro spot XRF:** for precise analysis of the smallest samples and features.
- Handheld XRF: for portable coatings analysis of parts too large or heavy to fit in a benchtop system.
- Electromagnetic gauges: for rapid thickness measurement of PCB copper, paint, anodising, electroplating and galvanising.

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